

LM324-MIL クワッド・オペアンプ

1 特長

- 広い電源電圧範囲
 - 単一電源: 3V~32V
 - デュアル電源: $\pm 1.5V$ ~ $\pm 16V$
- 電源電圧に影響されない低い電源消費電流: 0.8mA (標準値)
- 同相入力電圧範囲にグランドが含まれるため、グランド近くの直接センシングが可能
- 低い入力バイアスとオフセット・パラメータ
 - 入力オフセット電圧: 3mV (標準値)
 - 入力オフセット電流: 2nA (標準値)
 - 入力バイアス電流: 20nA (標準値)
- 差動入力電圧範囲が最大定格電源電圧と同じ: 32V
- 開ループ差動電圧増幅: 100V/mV (標準値)
- 内部的な周波数補償
- MIL-PRF-38535準拠の製品については、特に記述のない限り、すべてのパラメータはテスト済みです。他のすべての製品については、量産プロセスにすべてのパラメータのテストが含まれているとは限りません。

2 アプリケーション

- Blu-Rayプレイヤーおよびホーム・シアター
- 化学およびガス・センサ
- DVDレコーダーおよびプレイヤー
- デジタル・マルチメータ: ベンチおよびシステム
- デジタル・マルチメータ: ハンドヘルド
- フィールド・トランスマッタ: 温度センサ
- モータ制御: AC誘導、ブラシ付きDC、ブラシレスDC、高電圧、低電圧、永久磁石、ステッパー・モータ
- オシロスコープ
- TV: LCDおよびデジタル
- Modbusを使用した温度センサまたはコントローラ
- 重量計

3 概要

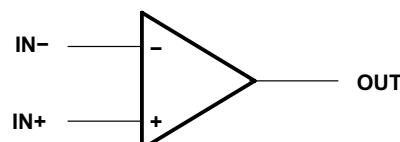
このデバイスは、4つの独立した高ゲインの周波数補償オペアンプで構成され、広い範囲の電圧を持つ単一または分割電源で動作するよう特に設計されています。

製品情報⁽¹⁾

型番	パッケージ	本体サイズ(公称)
LM324-MIL	SOIC (14)	8.65mm×3.91mm
	CDIP (14)	19.56mm×6.67mm
	PDIP (14)	19.30mm×6.35mm
	CFP (14)	9.21mm×5.97mm
	TSSOP (14)	5.00mm×4.40mm
	SO (14)	9.20mm×5.30mm
	SSOP (14)	6.20mm×5.30mm

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。

シンボル(各アンプ)



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English Data Sheet: [SLOS987](#)

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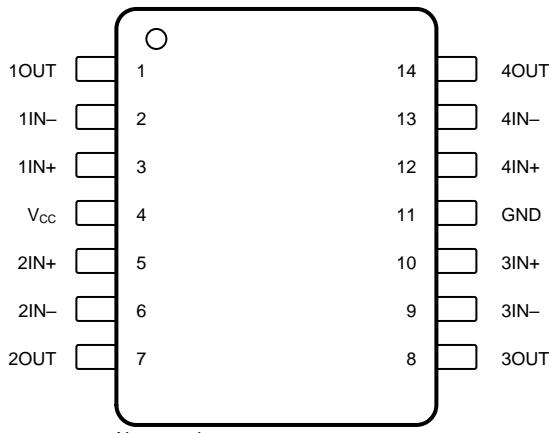
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4 改訂履歴

日付	改訂内容	注
2017年6月	*	初版

5 Pin Configuration and Functions

D, DB, J, N, NS, PW, W PACKAGE
14-Pin SOIC, SSOP, CDIP, PDIP, SO, TSSOP, CFP
(Top View)



Not to scale

Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
1IN-	2	I	Negative input
1IN+	3	I	Positive input
1OUT	1	O	Output
2IN-	6	I	Negative input
2IN+	5	I	Positive input
2OUT	7	O	Output
3IN-	9	I	Negative input
3IN+	10	I	Positive input
3OUT	8	O	Output
4IN-	13	I	Negative input
4IN+	12	I	Positive input
4OUT	14	O	Output
GND	11	—	Ground
NC	—	—	Do not connect
V _{cc}	4	—	Power supply

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply voltage, V_{CC} ⁽²⁾		±16	32	V
Differential input voltage, V_{ID} ⁽³⁾			±32	V
Input voltage, V_I (either input)		-0.3	32	V
Duration of output short circuit (one amplifier) to ground at (or below) $T_A = 25^\circ\text{C}$, $V_{CC} \leq 15\text{ V}$ ⁽⁴⁾		Unlimited		
Operating virtual junction temperature, T_J			150	°C
Case temperature for 60 seconds	FK package		260	°C
Storage temperature, T_{stg}		-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values (except differential voltages and V_{CC} specified for the measurement of I_{OS}) are with respect to the network GND.

(3) Differential voltages are at IN^+ , with respect to IN^- .

(4) Short circuits from outputs to V_{CC} can cause excessive heating and eventual destruction.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±500
		Charged-device model (CDM), per JEDEC specification JESD22-C101	±1000

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		3	30	V
V_{CM}	Common-mode voltage		0	$V_{CC} - 2$	V
T_A	Operating free air temperature		0	70	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾	D (SOIC)	DB (SSOP)	N (PDIP)	NS (SO)	PW (TSSOP)	J (CDIP)	W (CFP)	UNIT
	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
$R_{\theta JA}$ ⁽²⁾⁽³⁾ Junction-to-ambient thermal resistance	86	86	80	76	113	—	—	°C/W
$R_{\theta JC}$ ⁽⁴⁾ Junction-to-case (top) thermal resistance	—	—	—	—	—	15.05	14.65	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.
- (2) Short circuits from outputs to V_{CC} can cause excessive heating and eventual destruction.
- (3) Maximum power dissipation is a function of $T_{J(\max)}$, $R_{\theta JA}$, and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_{J(\max)} - T_A)/R_{\theta JA}$. Operating at the absolute maximum T_J of 150°C can affect reliability.
- (4) Maximum power dissipation is a function of $T_{J(\max)}$, $R_{\theta JA}$, and T_C . The maximum allowable power dissipation at any allowable case temperature is $P_D = (T_{J(\max)} - T_C)/R_{\theta JC}$. Operating at the absolute maximum T_J of 150°C can affect reliability.

6.5 Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS ⁽¹⁾		$T_A^{(2)}$	MIN	TYP ⁽³⁾	MAX	UNIT	
V_{IO}	Input offset voltage	$V_{CC} = 5\text{ V}$ to MAX, $V_{IC} = V_{ICRmin}$, $V_O = 1.4\text{ V}$		25°C	3	7	mV		
				Full range	9				
I_{IO}	Input offset current	$V_O = 1.4\text{ V}$		25°C	2	50	nA		
				Full range	150				
I_{IB}	Input bias current	$V_O = 1.4\text{ V}$		25°C	-20	-250	nA		
				Full range	-500				
V_{ICR}	Common-mode input voltage range	$V_{CC} = 5\text{ V}$ to MAX		25°C	0 to $V_{CC} - 1.5$	V			
				Full range	0 to $V_{CC} - 2$				
V_{OH}	High-level output voltage	$R_L = 2\text{ k}\Omega$		25°C	$V_{CC} - 1.5$		V		
		$R_L = 10\text{ k}\Omega$		25°C					
		$V_{CC} = \text{MAX}$	$R_L = 2\text{ k}\Omega$	Full range	26				
			$R_L \geq 10\text{ k}\Omega$	Full range	27	28			
V_{OL}	Low-level output voltage	$R_L \leq 10\text{ k}\Omega$		Full range	5	20	mV		
A_{VD}	Large-signal differential voltage amplification	$V_{CC} = 15\text{ V}$, $V_O = 1\text{ V}$ to 11 V , $R_L \geq 2\text{ k}\Omega$		25°C	25	100	V/mV		
				Full range	15				
CMRR	Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$		25°C	65	80	dB		
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC} / \Delta V_{IO}$)			25°C	65	100	dB		
V_{O1} / V_{O2}	Crosstalk attenuation	$f = 1\text{ kHz}$ to 20 kHz		25°C	120		dB		
I_O	Output current	$V_{CC} = 15\text{ V}$, $V_{ID} = 1\text{ V}$, $V_O = 0$	Source	25°C	-20	-30	-60	mA	
				Full range	-10				
		$V_{CC} = 15\text{ V}$, $V_{ID} = -1\text{ V}$, $V_O = 15\text{ V}$	Sink	25°C	10	20			
				Full range	5				
I_{OS}	Short-circuit output current	$V_{ID} = -1\text{ V}$, $V_O = 200\text{ mV}$		25°C	12	30	μA	mA	
		$V_{CC} = 5\text{ V}$, $V_O = 0$, GND at -5 V		25°C	± 40	± 60			
I_{CC}	Supply current (four amplifiers)	$V_O = 2.5\text{ V}$, no load		Full range	0.7	1.2	mA		
		$V_{CC} = \text{MAX}$, $V_O = 0.5 V_{CC}$, no load		Full range	1.4	3			

(1) All characteristics are measured under open-loop conditions, with zero common-mode input voltage, unless otherwise specified. MAX V_{CC} for testing purposes is 30 V .

(2) Full range is 0°C to 70°C for LM324-MIL.

(3) All typical values are at $T_A = 25^\circ\text{C}$

6.6 Operating Conditions

$V_{CC} = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS		TYP	UNIT
SR	Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 30\text{ pF}$, $V_I = \pm 10\text{ V}$ (see Figure 7)		0.5	$\text{V}/\mu\text{s}$
B_1	Unity-gain bandwidth	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$ (see Figure 7)		1.2	MHz
V_n	Equivalent input noise voltage	$R_S = 100\text{ }\Omega$, $V_I = 0\text{ V}$, $f = 1\text{ kHz}$ (see Figure 8)		35	$\text{nV}/\sqrt{\text{Hz}}$

6.7 Typical Characteristics

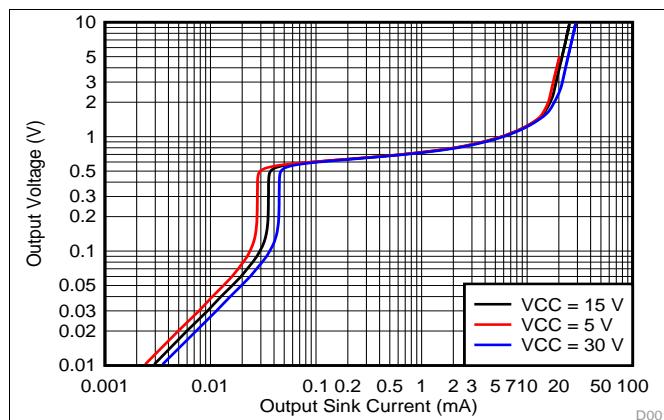


Figure 1. Output Sinking Characteristics

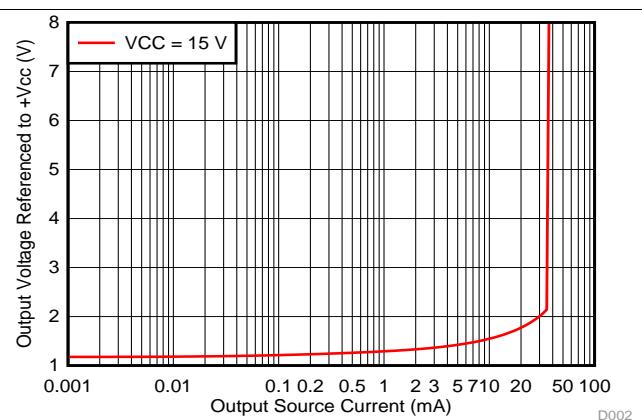


Figure 2. Output Sourcing Characteristics

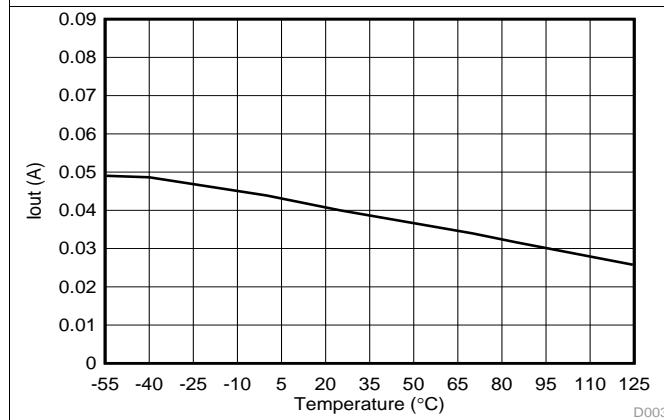


Figure 3. Source Current Limiting

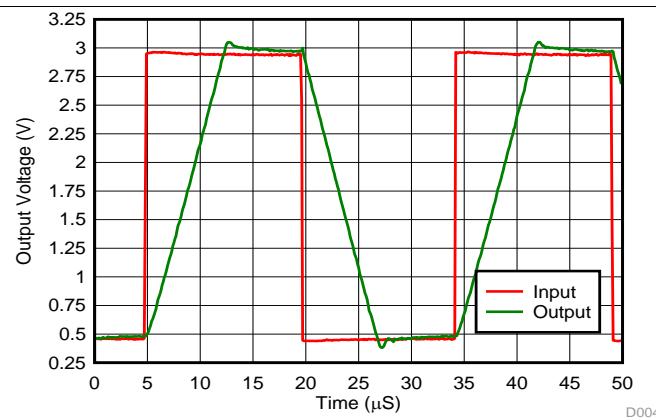


Figure 4. Voltage Follower Large Signal Response (50 pF)

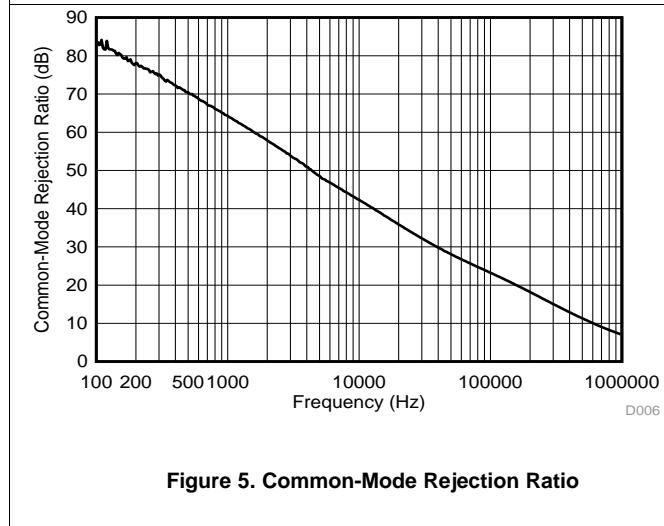
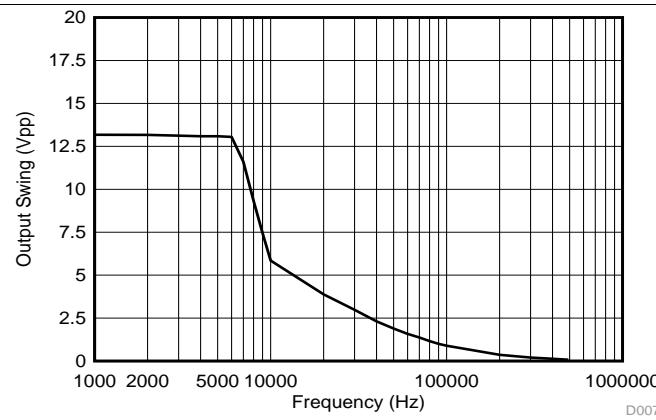


Figure 5. Common-Mode Rejection Ratio

Figure 6. Maximum Output Swing vs. Frequency
($V_{CC} = 15\text{ V}$)

7 Parameter Measurement Information

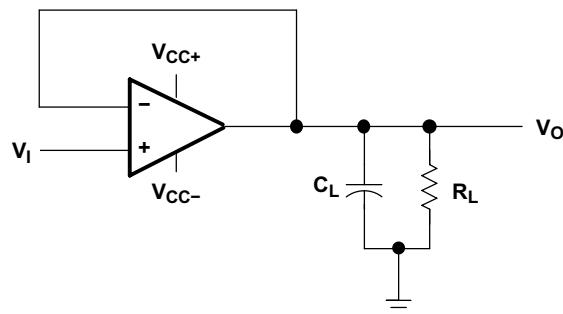


Figure 7. Unity-Gain Amplifier

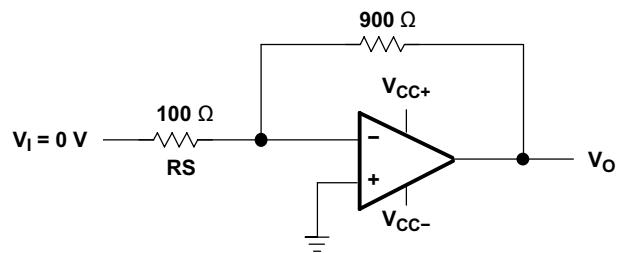


Figure 8. Noise-Test Circuit

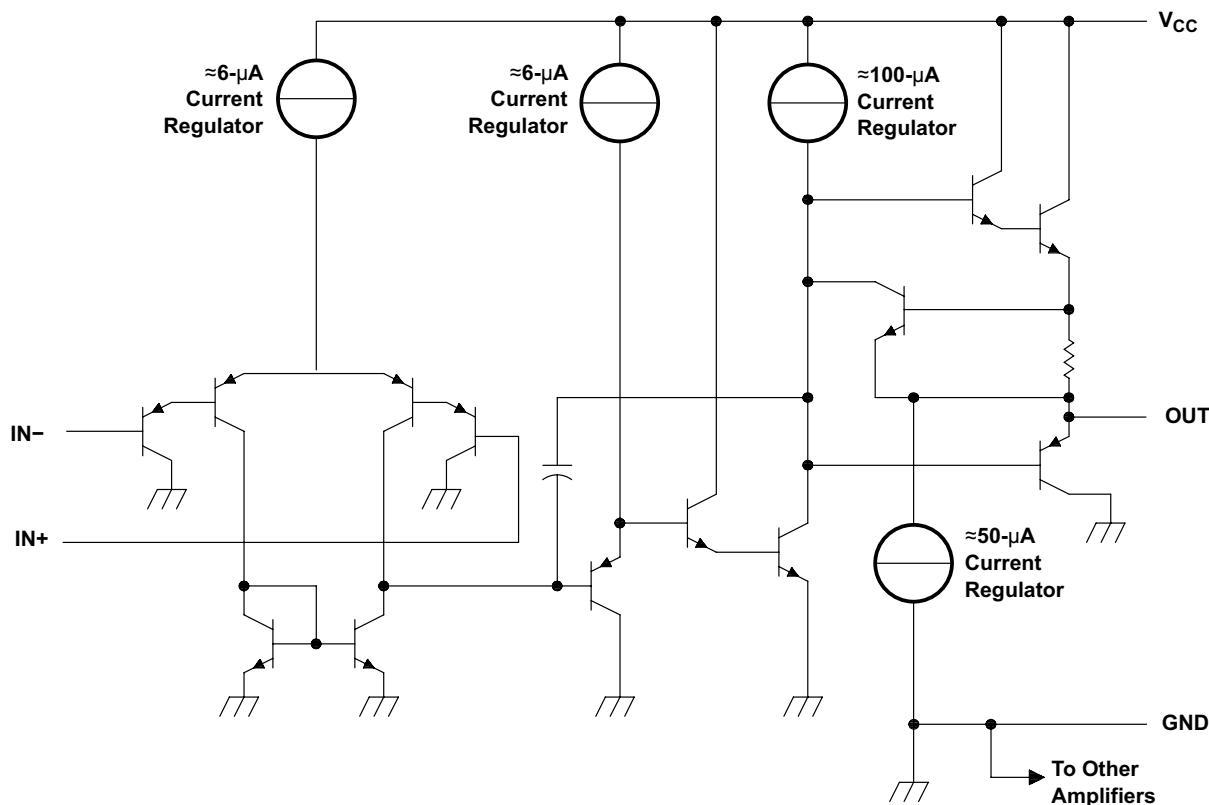
8 Detailed Description

8.1 Overview

The device consists of four independent high-gain frequency-compensated operational amplifiers that are designed specifically to operate from a single supply over a wide range of voltages. Operation from split supplies also is possible if the difference between the two supplies is 3 V to 32 V, and V_{CC} is at least 1.5 V more positive than the input common-mode voltage. The low supply-current drain is independent of the magnitude of the supply voltage.

Applications include transducer amplifiers, DC amplification blocks, and all the conventional operational-amplifier circuits that now can be more easily implemented in single-supply-voltage systems. For example, the LM324-MIL device can be operated directly from the standard 5-V supply that is used in digital systems and provides the required interface electronics, without requiring additional ± 15 -V supplies.

8.2 Functional Block Diagram



COMPONENT COUNT (total device)	
Epi-FET	1
Transistors	95
Diodes	4
Resistors	11
Capacitors	4

8.3 Feature Description

8.3.1 Unity-Gain Bandwidth

Gain bandwidth product is found by multiplying the measured bandwidth of an amplifier by the gain at which that bandwidth was measured. These devices have a high gain bandwidth of 1.2 MHz.

8.3.2 Slew Rate

The slew rate is the rate at which an operational amplifier can change its output when there is a change on the input. These devices have a 0.5-V/ μ s slew rate.

8.3.3 Input Common Mode Range

The valid common mode range is from device ground to $V_{CC} - 1.5$ V ($V_{CC} - 2$ V across temperature). Inputs may exceed V_{CC} up to the maximum V_{CC} without device damage. At least one input must be in the valid input common mode range for output to be correct phase. If both inputs exceed valid range then output phase is undefined. If either input is less than -0.3 V then input current should be limited to 1 mA and output phase is undefined.

8.4 Device Functional Modes

The device is powered on when the supply is connected. This device can be operated as a single supply operational amplifier or dual supply amplifier depending on the application.

9 Application and Implementation

NOTE

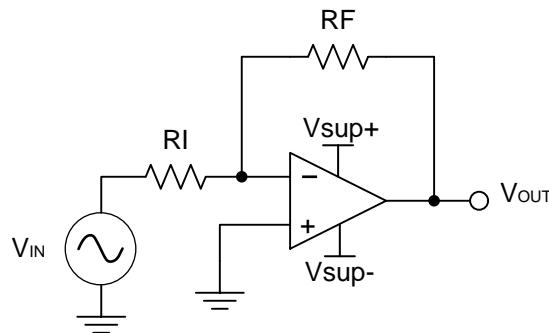
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The LM324-MIL operational amplifier is useful in a wide range of signal conditioning applications. Inputs can be powered before VCC for flexibility in multiple supply circuits.

9.2 Typical Application

A typical application for an operational amplifier in an inverting amplifier. This amplifier takes a positive voltage on the input, and makes it a negative voltage of the same magnitude. In the same manner, it also makes negative voltages positive.



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Figure 9. Application Schematic

9.2.1 Design Requirements

The supply voltage must be chosen such that it is larger than the input voltage range and output range. For instance, this application will scale a signal of ± 0.5 V to ± 1.8 V. Setting the supply at ± 12 V is sufficient to accommodate this application.

9.2.2 Detailed Design Procedure

Determine the gain required by the inverting amplifier using [Equation 1](#) and [Equation 2](#):

$$A_v = \frac{V_{OUT}}{V_{IN}} \quad (1)$$

$$A_v = \frac{1.8}{-0.5} = -3.6 \quad (2)$$

Once the desired gain is determined, choose a value for RI or RF. Choosing a value in the kilohm range is desirable because the amplifier circuit will use currents in the milliamp range. This ensures the part will not draw too much current. This example will choose 10 k Ω for RI which means 36 k Ω will be used for RF. This was determined by [Equation 3](#).

$$A_v = -\frac{RF}{RI} \quad (3)$$

Typical Application (continued)

9.2.3 Application Curve

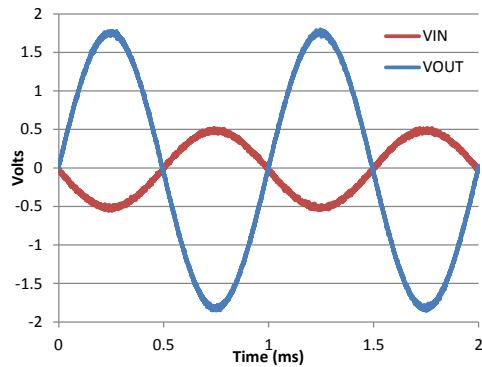


Figure 10. Input and Output Voltages of the Inverting Amplifier

10 Power Supply Recommendations

CAUTION

Supply voltages larger than 32 V for a single supply, or outside the range of ± 16 V for a dual supply can permanently damage the device (see the *Absolute Maximum Ratings*).

Place 0.1- μ F bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high impedance power supplies. For more detailed information on bypass capacitor placement, refer to the *Layout*.

11 Layout

11.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole, as well as the operational amplifier. Bypass capacitors are used to reduce the coupled noise by providing low impedance power sources local to the analog circuitry.
 - Connect low-ESR, $0.1\text{-}\mu\text{F}$ ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V_+ to ground is applicable for single supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If it is not possible to keep them separate, it is much better to cross the sensitive trace perpendicular as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. Keeping RF and RG close to the inverting input minimizes parasitic capacitance, as shown in [Layout Examples](#).
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

11.2 Layout Examples

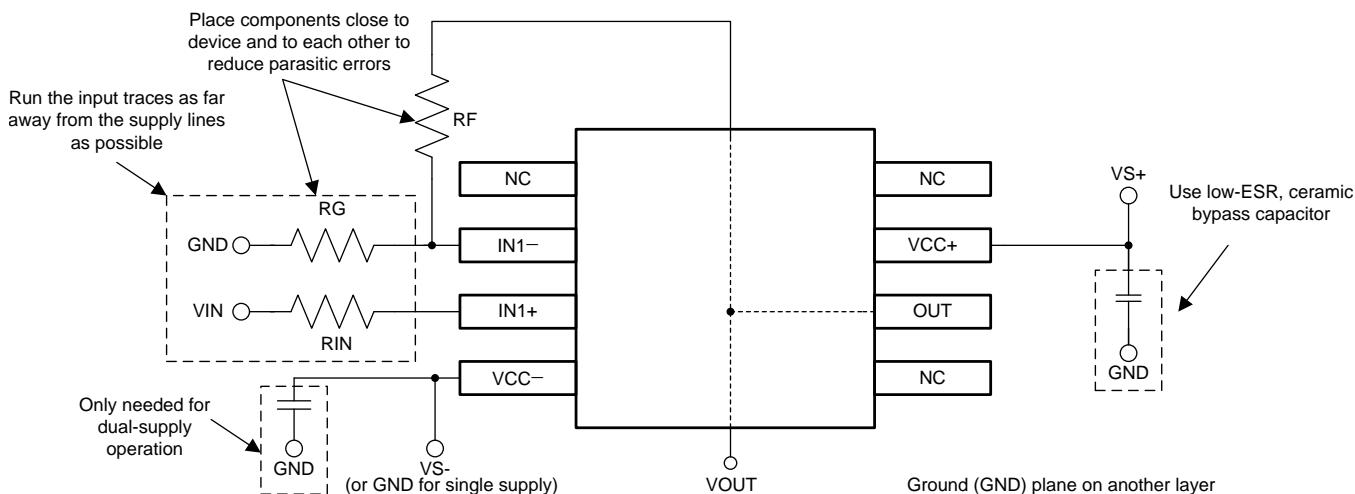


Figure 11. Operational Amplifier Board Layout for Noninverting Configuration

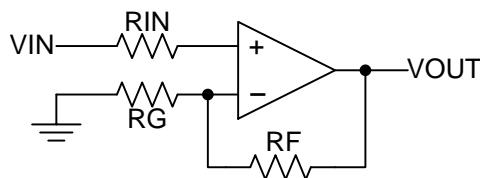


Figure 12. Operational Amplifier Schematic for Noninverting Configuration

12 デバイスおよびドキュメントのサポート

12.1 ドキュメントのサポート

12.1.1 関連資料

関連資料については、以下を参照してください。

[『基板のレイアウト技法』、SLOA089](#)

12.2 ドキュメントの更新通知を受け取る方法

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12.3 コミュニティ・リソース

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12.5 静電気放電に関する注意事項



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12.6 Glossary

[SLYZ022 — TI Glossary](#).

This glossary lists and explains terms, acronyms, and definitions.

13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。これらの情報は、指定のデバイスに対して提供されている最新のデータです。このデータは予告なく変更されることがあります、ドキュメントが改訂される場合もあります。このデータシートのブラウザ対応版については、左側にあるナビゲーションを参照してください。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LM324 MWA	ACTIVE	WAFERSALE	YS	0	1	RoHS & Green	Call TI	Level-1-NA-UNLIM	-40 to 85		Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

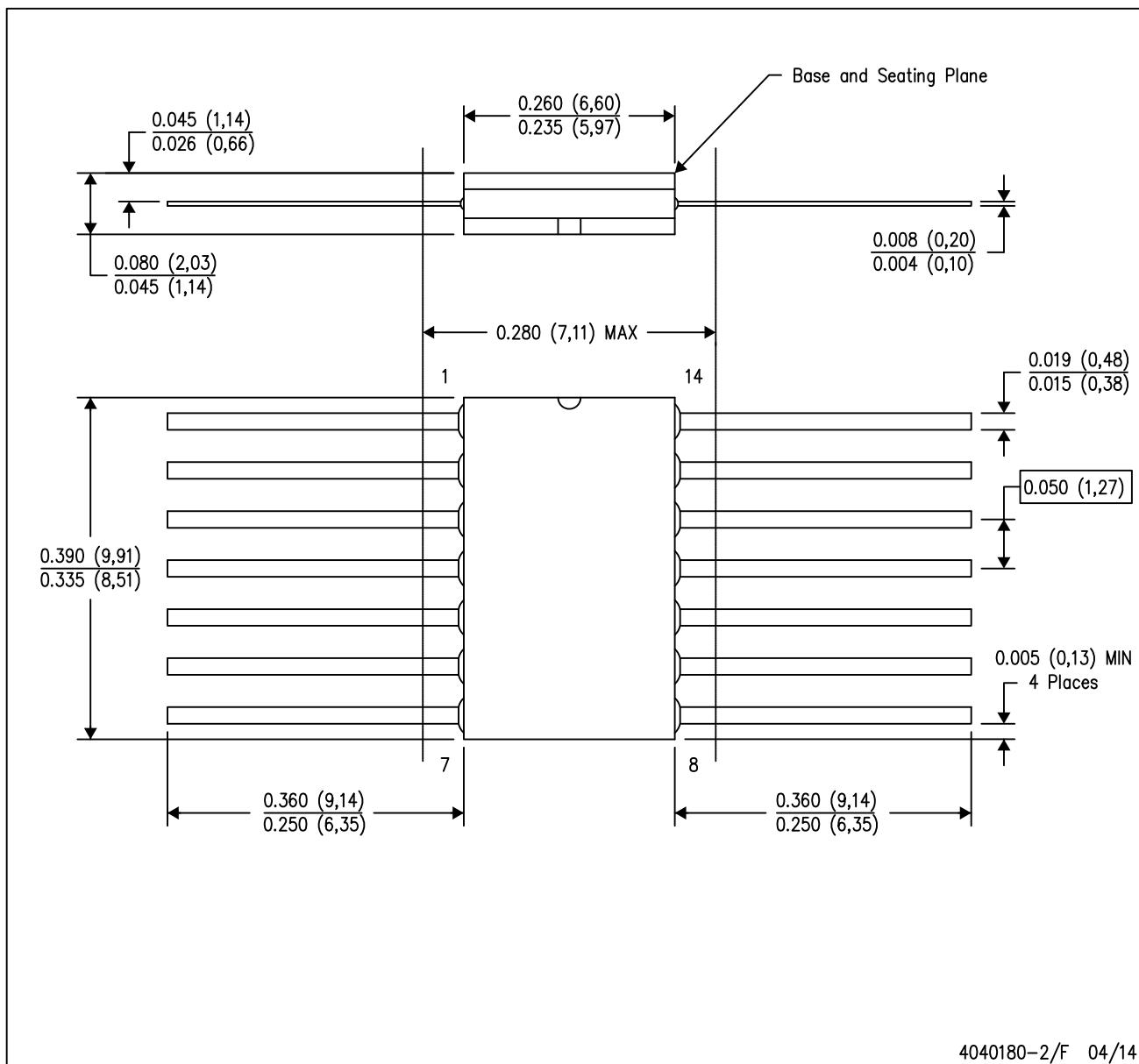
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MECHANICAL DATA

W (R-GDFP-F14)

CERAMIC DUAL FLATPACK



4040180-2/F 04/14

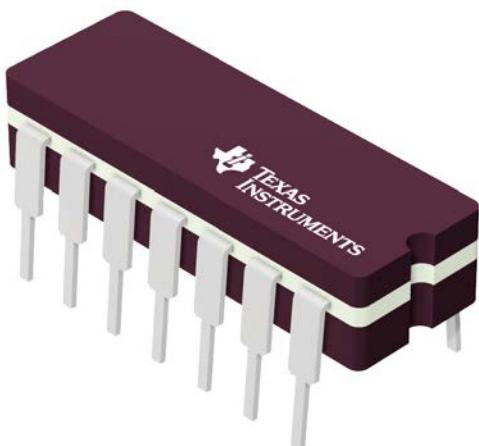
- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package can be hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only.
 - E. Falls within MIL STD 1835 GDFP1-F14

GENERIC PACKAGE VIEW

J 14

CDIP - 5.08 mm max height

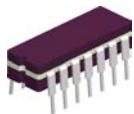
CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040083-5/G

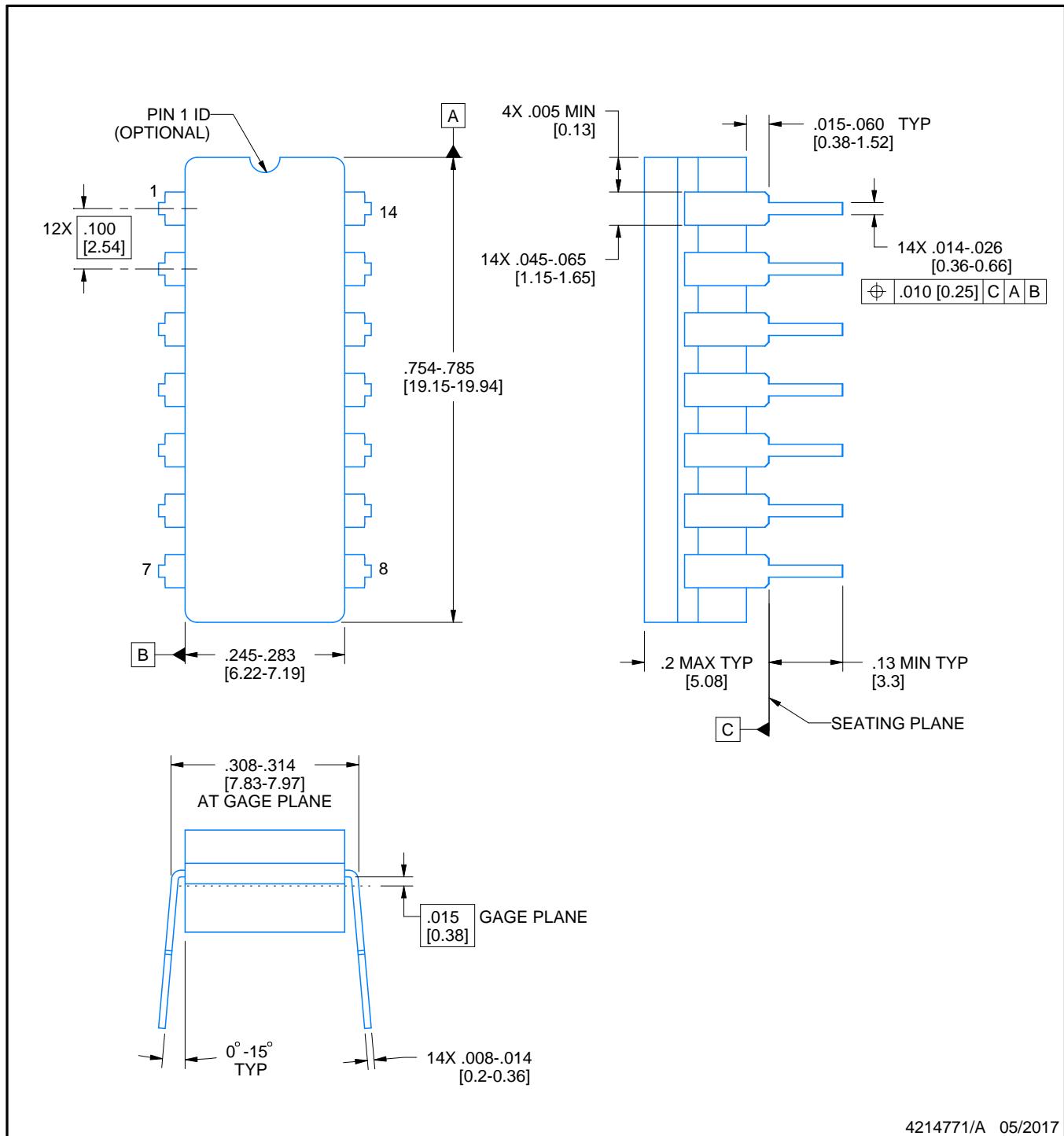
J0014A



PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



4214771/A 05/2017

NOTES:

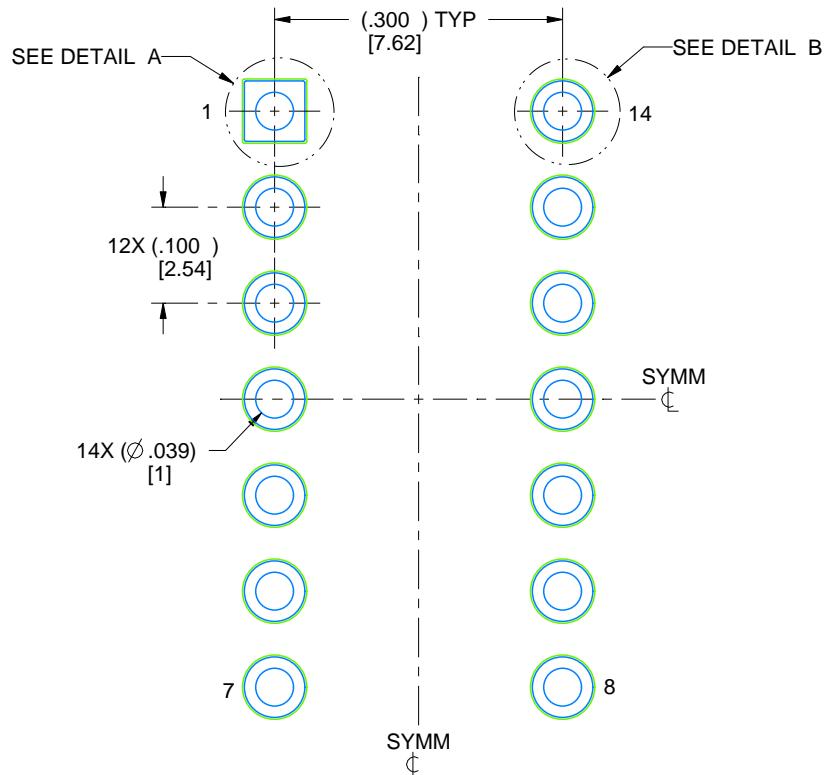
1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

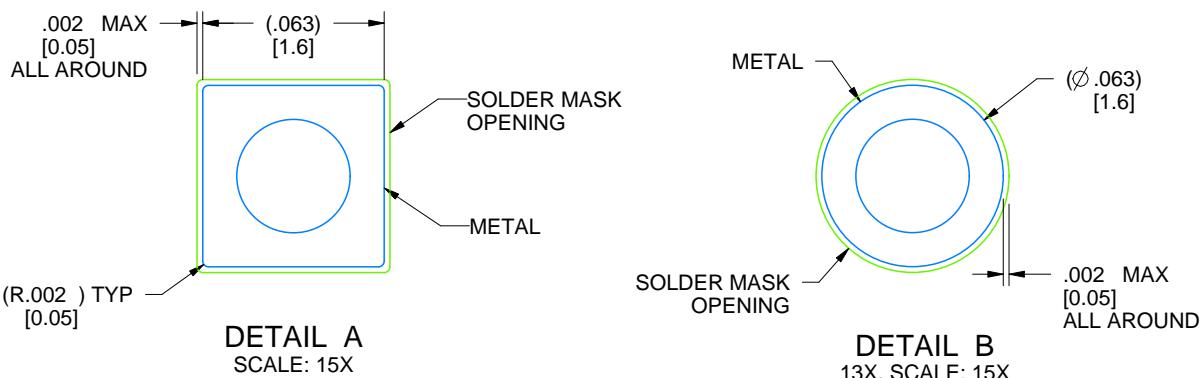
J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



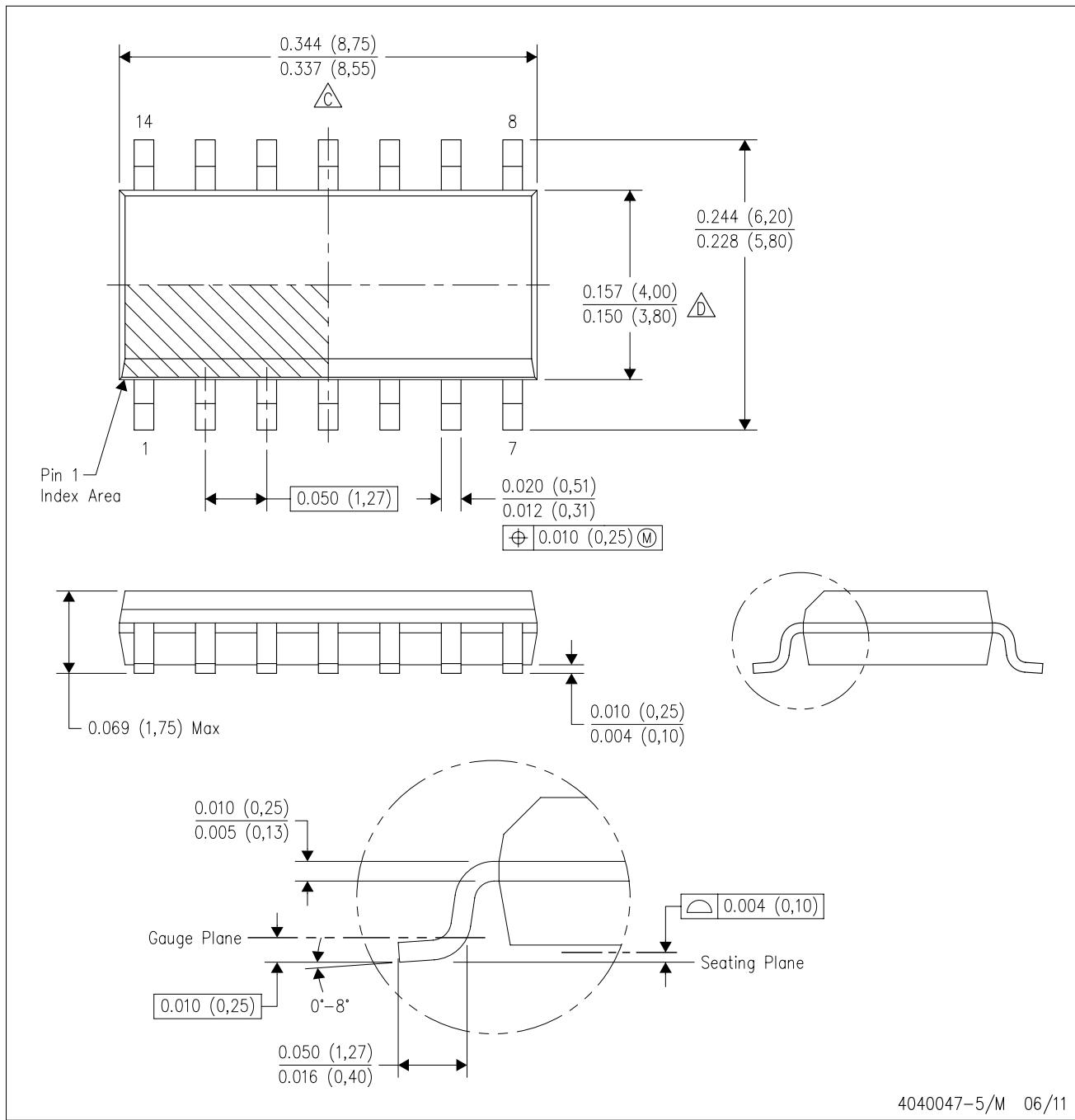
LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X



4214771/A 05/2017

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

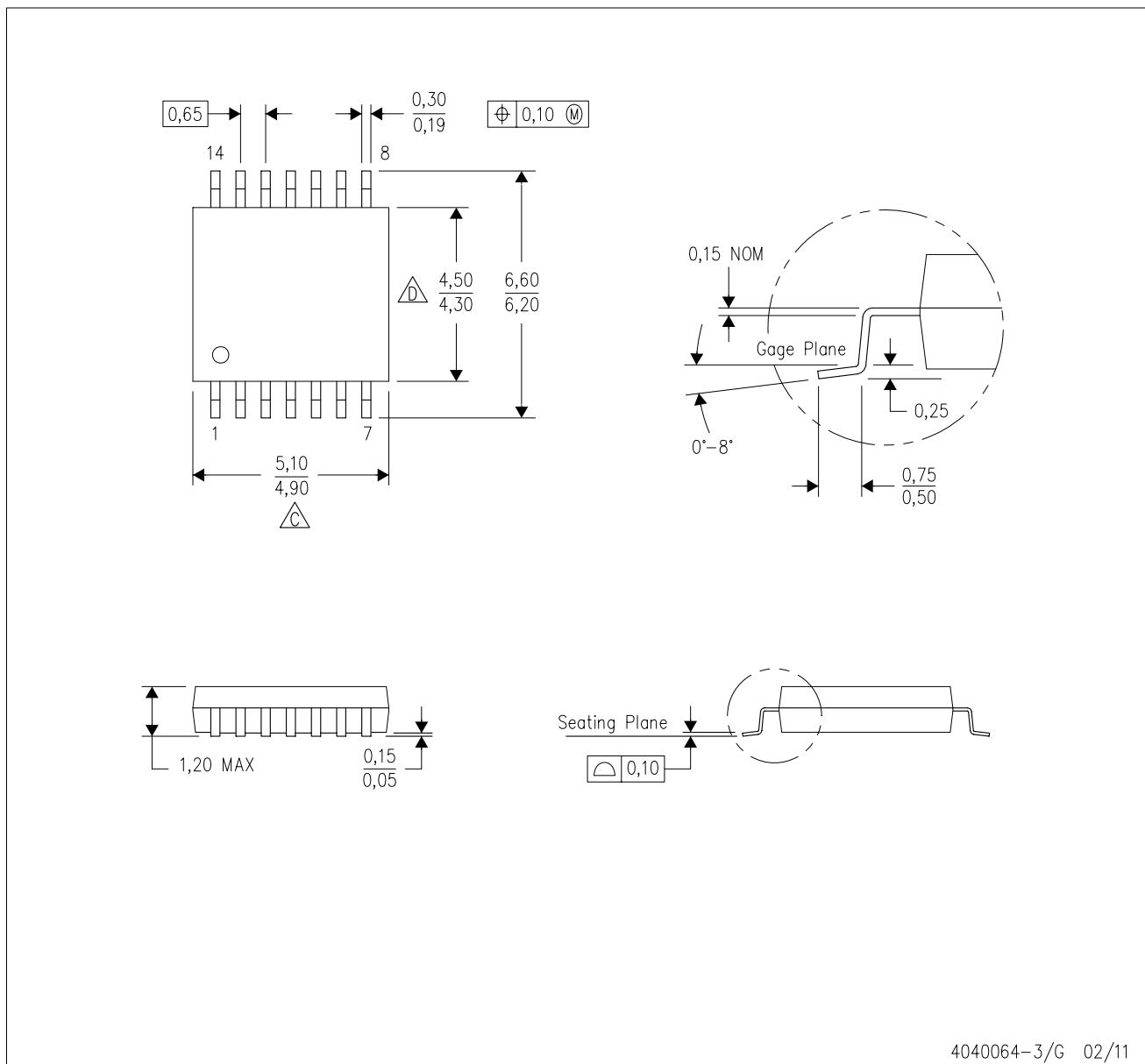
C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.

D Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
E. Reference JEDEC MS-012 variation AB.

MECHANICAL DATA

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4040064-3/G 02/11

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

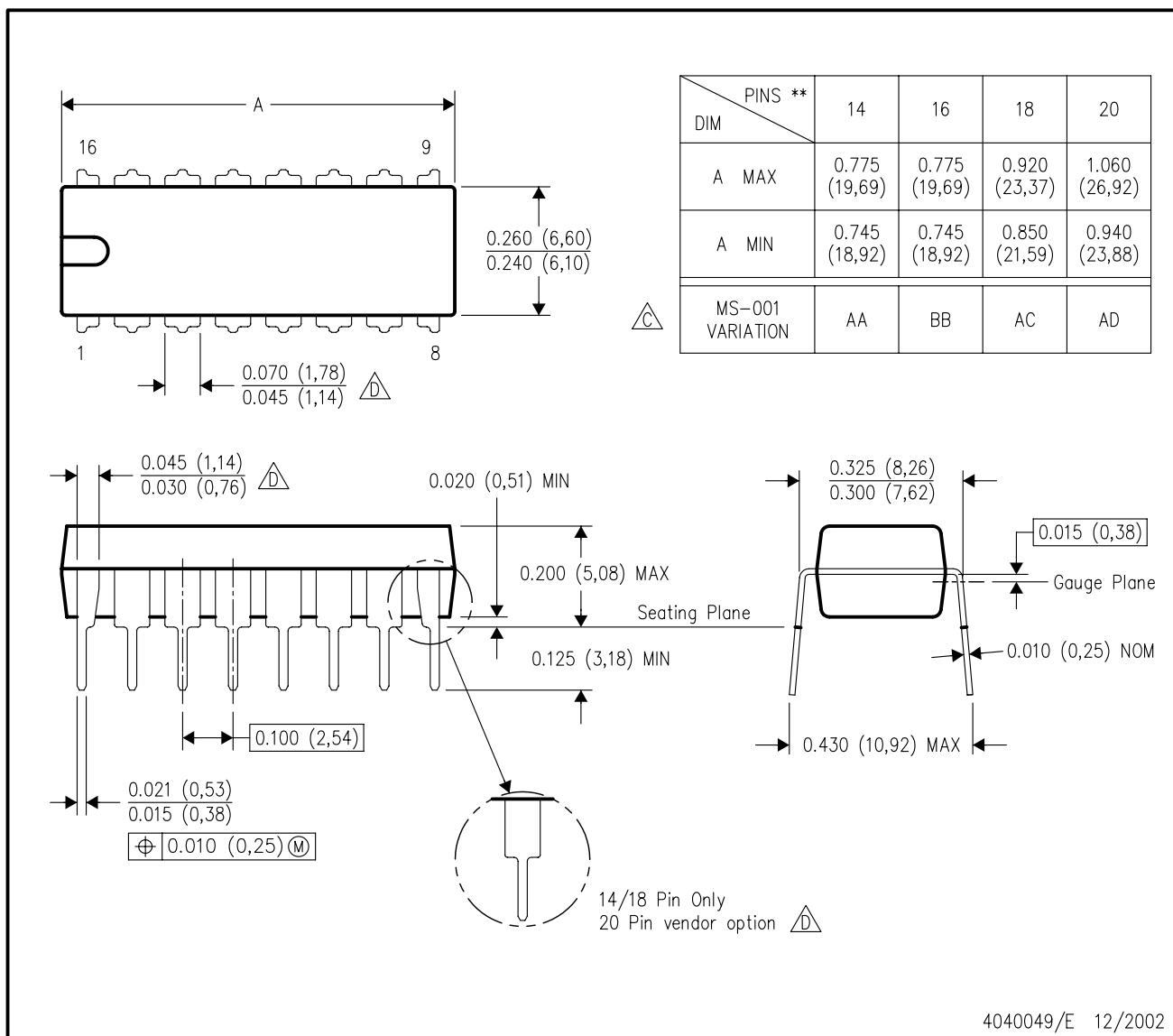
D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



4040049/E 12/2002

NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.

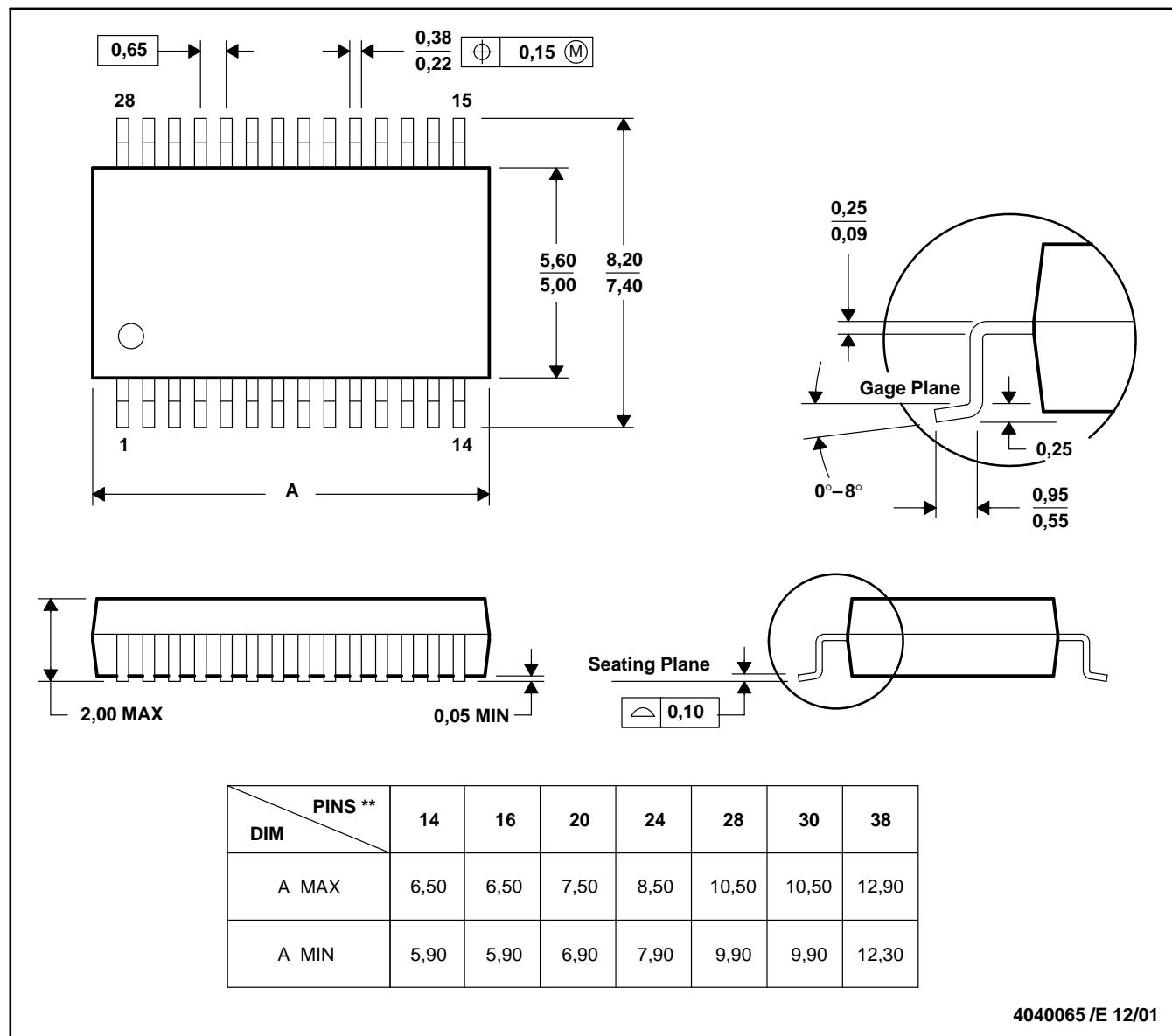
△ C Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

△ D The 20 pin end lead shoulder width is a vendor option, either half or full width.

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



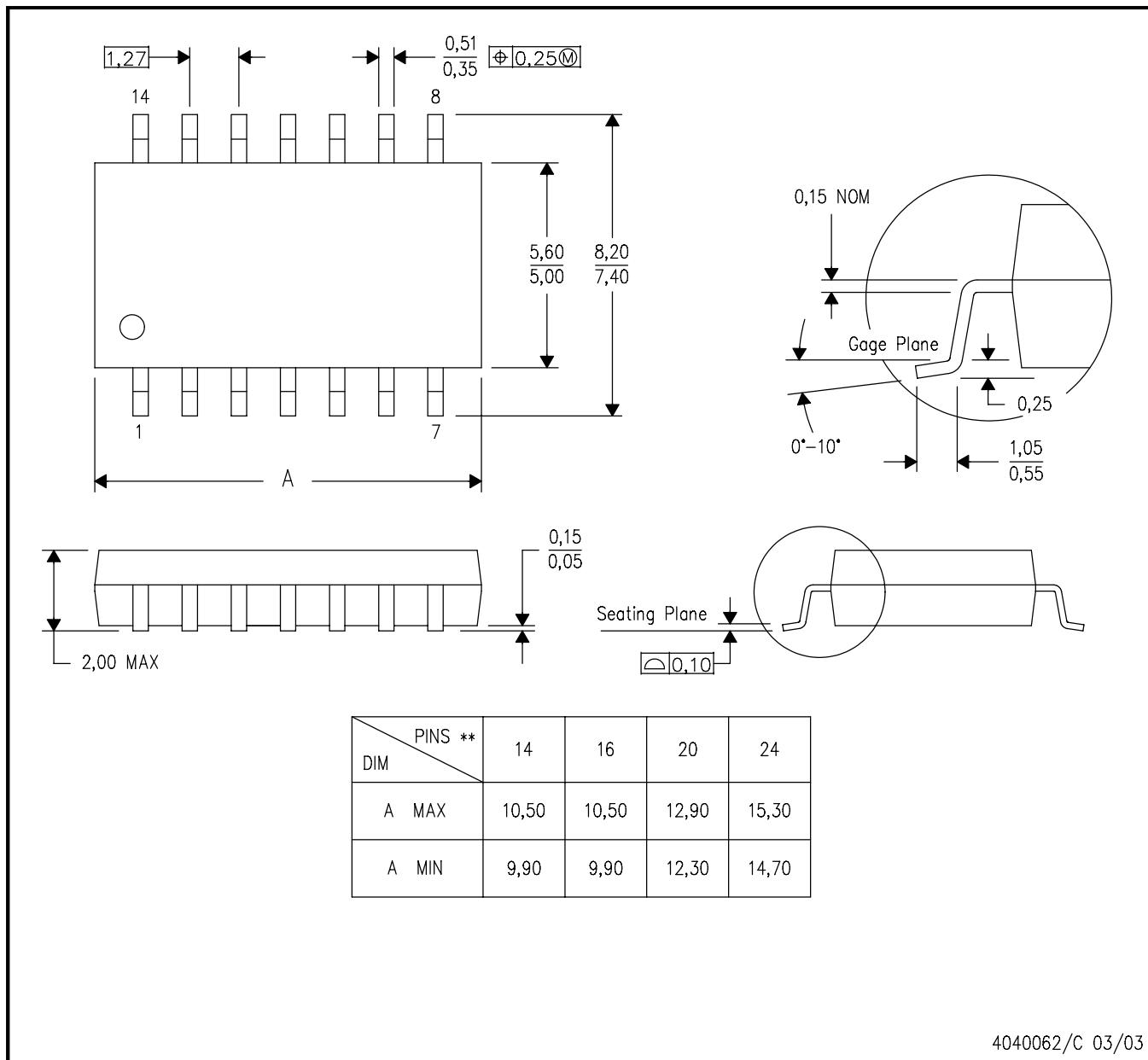
- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 - D. Falls within JEDEC MO-150

MECHANICAL DATA

NS (R-PDSO-G)**

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

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